

Search Notes

Application No.

10/045,783

Examiner

Alonzo Chambliss

Applicant(s)

LEE ET AL.

Art Unit

2827

SEARCHED

Class	Subclass	Date	Examiner
438	22,26,48, 106-108, 125-127,		
	584,597,		
	611-615,		
	618,622,		
	623,629,		
	637,639,	689-693,	700
	Foreign		
	342,343,		
	348,		
228	101,178,		
	179,1,		
	180,1,		
	180,21,		
	180,22	11/6/2003	AC

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
438	all		
228	subclass		
	above	11/10/2003	AC

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East search (all databases)	11/6/2003	AC
IEEE/NPL search	11/6/2003	AC

Search Notes (continued)

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2827

SEARCHED

Class	Subclass	Date	Examiner
29	592,592.1, 825,829, 832,		
	837-846,		
	874-876,		
	884		
361	600,679,		
	748,760,		
	767,777,		
	772-774,		
	807,808,		
257	678,690,		
	692,730,		
	734-738,		
	773,774,	778-781	
	786,787	11/6/2003	AC

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
29	all		
	subclass		
	above	11/10/2003	AC

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR